# 2SA1096, 2SA1096A

## Silicon PNP epitaxial planar type

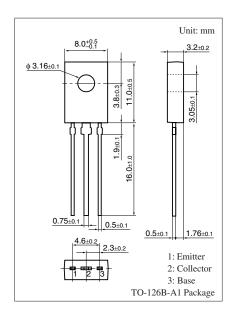
For low-frequency power amplification Complementary to 2SC2497, 2SC2497A

### ■ Features

- Output of 5 W can be obtained by a complementary pair with 2SC2497 and 2SC2497A
- TO-126B package which requires no insulation plate for installation to the heat sink

## ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Er	$V_{CBO}$	-70	V	
Collector-emitter voltage	2SA1096	V <sub>CEO</sub>	-50	V
(Base open)	2SA1096A		-60	
Emitter-base voltage (Coll	V <sub>EBO</sub>	-5	V	
Collector current	$I_C$	-2	A	
Peak collector current	$I_{CP}$	-3	A	
Collector power dissipation	P <sub>C</sub>	1.2	W	
Junction temperature	T <sub>j</sub>	150	°C	
Storage temperature	$T_{stg}$	-55 to +150	°C	



## ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

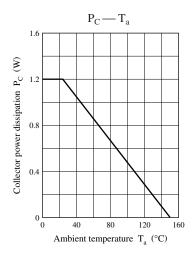
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)		V <sub>CBO</sub>	$I_C = -1 \text{ mA}, I_E = 0$	-70			V
Collector-emitter voltage	2SA1096	V <sub>CEO</sub>	$I_C = -2 \text{ mA}, I_B = 0$	-50			V
(Base open)	2SA1096A			-60			
Collector-base cutoff current (Emitter open)		$I_{CBO}$	$V_{CB} = -20 \text{ V}, I_E = 0$			-1	μΑ
Collector-emitter cutoff current (Base open)		I <sub>CEO</sub>	$V_{CE} = -10 \text{ V}, I_{B} = 0$			-100	μΑ
Emitter-base cutoff current (Collector open)		$I_{EBO}$	$V_{EB} = -5 \text{ V}, I_C = 0$			-10	μΑ
Forward current transfer ratio *1,2		$h_{FE}$	$V_{CE} = -5 \text{ V}, I_{C} = -1 \text{ A}$	80		220	_
Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	$I_C = -1.5 \text{ A}, I_B = -0.15 \text{ A}$			-1	V
Base-emitter saturation voltage		V <sub>BE(sat)</sub>	$I_C = -1.5 \text{ A}, I_B = -0.15 \text{ A}$			-1.5	V
Transition frequency		$f_T$	$V_{CB} = -5 \text{ V}, I_E = 0.5 \text{ A}, f = 200 \text{ MHz}$		150		MHz
Collector output capacitance		C <sub>ob</sub>	$V_{CB} = -20 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		55		pF
(Common base, input open circuited)							

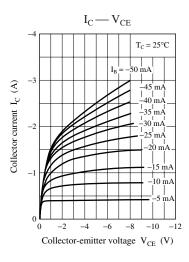
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

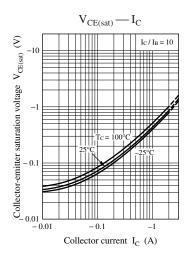
#### 2. \*1: Pulse measurement

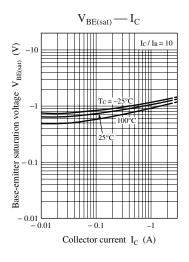
#### \*2: Rank classification

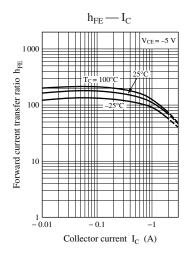
Rank	Q	R		
$h_{FE}$	80 to 160	120 to 220		

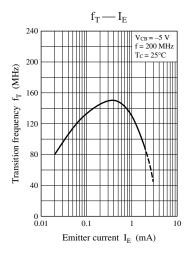


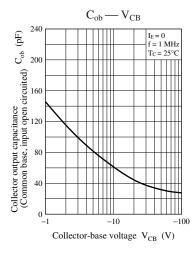


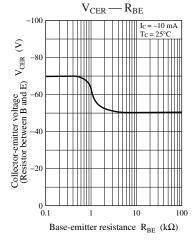


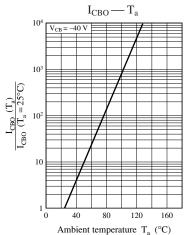


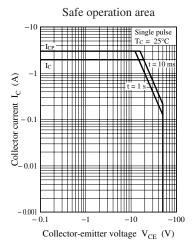












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